

<b>Issue Classification</b>				Application/Control No.	Applicant(s)/Patent under Reexamination	
				10/616,896	QUAKE ET AL.	
				Examiner	Art Unit	
				Patrick J. Lee	2878	

<b>ISSUE CLASSIFICATION</b>					
ORIGINAL		CROSS REFERENCE(S)			
CLASS	SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)		
250	234	250	458.1		
<b>INTERNATIONAL CLASSIFICATION</b>					
H 0 1 J	3/14				
H 0 1 J	40/14				
H 0 1 J	5/16				
	/				
	/				
Patrick J. Lee <i>11/14/2005</i> (Assistant Examiner) (Date)		 <b>DAVID PORTA</b> <b>SUPERVISORY PATENT EXAMINER</b> <b>TECHNOLOGY CENTER 2800</b> (Primary Examiner) (Date)		Total Claims Allowed: 55	
 <i>JHL</i> <i>4605</i> (Legal Instruments Examiner) (Date)				O.G. Print Claim(s) 31	O.G. Print Fig. 1

<input checked="" type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
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